MOSFET – Power, Single, N-Channel, SO-8FL 25 V, 269 A

Features

- Integrated Schottky Diode
- Optimized Design to Minimize Conduction and Switching Losses
- Optimized Package to Minimize Parasitic Inductances
- Optimized material for improved thermal performance
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- High Performance DC-DC Converters
- System Voltage Rails
- Netcom, Telecom
- Servers & Point of Load

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Units
Drain-to-Source Voltage	V_{DSS}	25	٧
Gate-to-Source Voltage	V_{GS}	±20	V
Continuous Drain Current $R_{\theta JA}$ (T_A = 25°C, Note 1)	Ι _D	43	Α
Power Dissipation $R_{\theta JA}$ (T_A = 25°C, Note 1)	P _D	2.70	W
Continuous Drain Current $R_{\theta JC}$ ($T_C = 25^{\circ}C$, Note 1)	I _D	269	Α
Power Dissipation $R_{\theta JC}$ ($T_C = 25^{\circ}C$, Note 1)	P _D	104	W
Pulsed Drain Current (t _p = 10 μs)	I _{DM}	505	Α
Single Pulse Drain-to-Source Avalanche Energy (Note 1) ($I_L = 51 \text{ A}_{pk}, L = 0.3 \text{ mH}$)	E _{AS}	390	mJ
Drain to Source dV/dt	dV/dt	7	V/ns
Maximum Junction Temperature	T _{J(max)}	150	°C
Storage Temperature Range	T _{STG}	–55 to 150	°C
Lead Temperature Soldering Reflow (SMD Styles Only), Pb-Free Versions (Note 2)	T _{SLD}	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Values based on copper area of 645 mm² (or 1 in²) of 2 oz copper thickness and FR4 PCB substrate.
- For more information, please refer to our Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.
- 3. This is the absolute maximum rating. Parts are 100% UIS tested at T_J = 25°C, V_{GS} = 10 V, I_L = 33 A, E_{AS} = 164 mJ.



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V _{GS}	MAX R _{DS(on)}	TYP Q _{GTOT}
4.5 V	1.4 m Ω	26 nC
10 V	$0.9~\text{m}\Omega$	56 nC

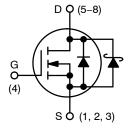
PIN CONNECTIONS

SO8-FL (5 x 6 mm)



(Top View) (Bottom View)

N-CHANNEL MOSFET



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

THERMALCHARACTERISTICS

Parameter	Symbol	Max	Units
Thermal Resistance, Junction-to-Ambient (Note 1 and 4) Junction-to-Case (Note 1 and 4)	$egin{array}{l} R_{ hetaJA} \ R_{ hetaJC} \end{array}$	40.0 1.5	°C/W

^{4.} Thermal Resistance $R_{\theta JA}$ and $R_{\theta JC}$ as defined in JESD51–3.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1.0 mA		25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				34.5		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 20 V	T _J = 25 °C			500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= +20 V			+100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 1.0 \text{ mA}$		1.2		2.1	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.6		mV/°C
		V _{GS} = 10 V	I _D = 30 A		0.72	0.9	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V	I _D = 30 A		1.1	1.4	mΩ
Forward Transconductance	9FS	V _{DS} = 12 V, I _D = 15 A			119		S
CHARGES, CAPACITANCES & GATE RESIS	STANCE						
Input Capacitance	C _{ISS}				3923		
Output Capacitance	Coss	V _{GS} = 0 V, f = 1 MHz	z, V _{DS} = 12 V		2537		pF
Reverse Transfer Capacitance	C _{RSS}	1			114		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 12 V; I _D = 30 A			26		nC
Threshold Gate Charge	Q _{G(TH)}				2.9		
Gate-to-Source Charge	Q _{GS}				10.7		
Gate-to-Drain Charge	Q_{GD}				5.8		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 12 V; I _D = 30 A			56		nC
Gate Resistance	R _G	T _A = 25°C			1.0		Ω
SWITCHING CHARACTERISTICS, V _{GS} = 4.5	V (Note 5)			I			
Turn-On Delay Time	t _{d(ON)}				17.6		
Rise Time	t _r	Voc = 45 V Vpp = 18	2 V In = 15 A		55.1		ns ns
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 4.5 \text{ V}, V_{DD} = 12$ $R_{G} = 3.0$	Ω		29.4		
Fall Time	t _f				9.96		
SWITCHING CHARACTERISTICS, V _{GS} = 10	V (Note 5)	<u>I</u>					
Turn-On Delay Time	t _{d(ON)}				11.3		
Rise Time	t _r	Voc = 10 V Vpr	. – 12 V		44.2		1
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 10 V, V_{DD} = 12 V, I_{D} = 15 A, R_{G} = 3.0 Ω			39.2		ns
Fall Time	t _f				7.1		
DRAIN-SOURCE DIODE CHARACTERISTIC	cs	<u>.</u>					
		V _{GS} = 0 V,	T _J = 25°C		0.38	0.6	
Forward Diode Voltage	V_{SD}		T _J = 125°C		0.297		V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 30 A			61.3		
Charge Time	t _a				30.4		ns
Discharge Time	t _b				30.9		┪
Reverse Recovery Charge	Q _{RR}				66		nC
·					I		I

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

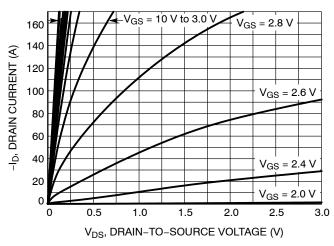


Figure 1. On-Region Characteristics

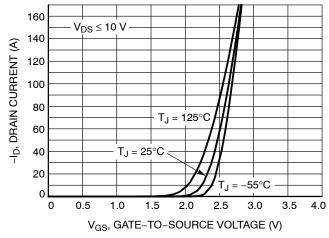


Figure 2. Transfer Characteristics

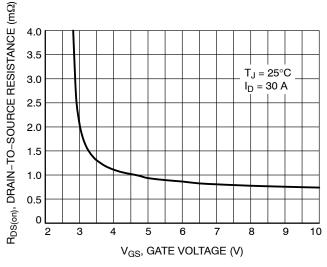


Figure 3. On-Resistance vs. Gate-to-Source Voltage

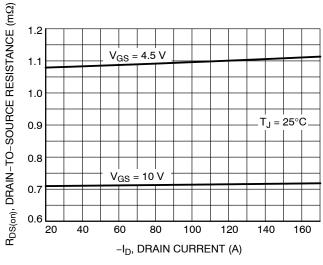


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

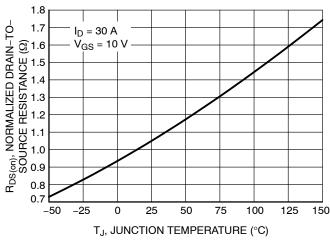


Figure 5. On–Resistance Variation with Temperature

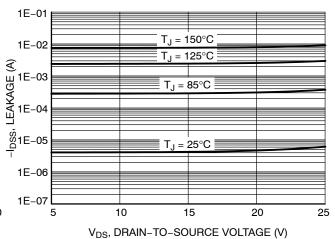


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

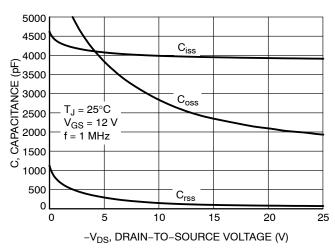


Figure 7. Capacitance Variation

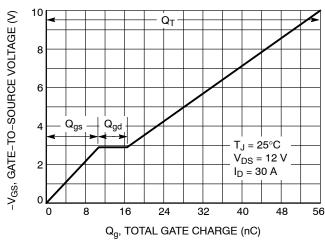


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

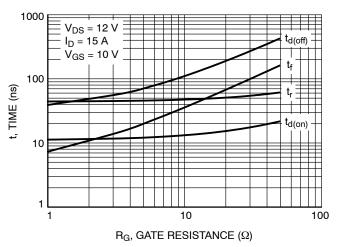


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

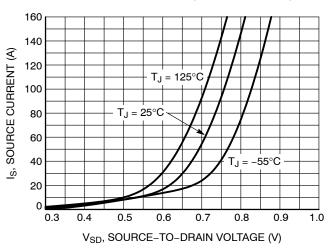


Figure 10. Diode Forward Voltage vs. Current

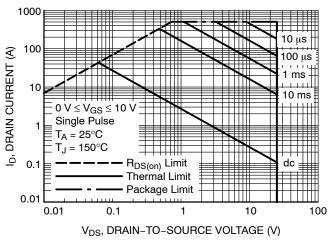


Figure 11. Maximum Rated Forward Biased Safe Operating Area

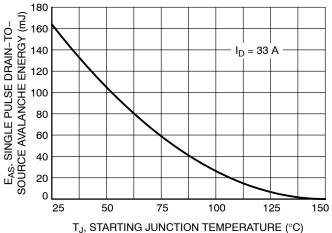


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

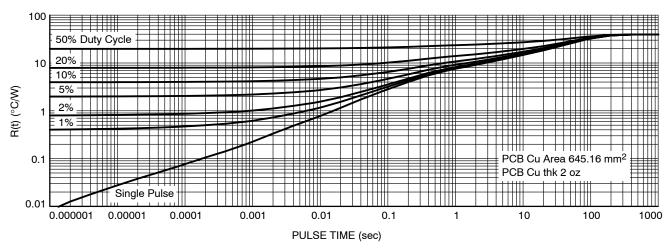


Figure 13. Thermal Characteristics

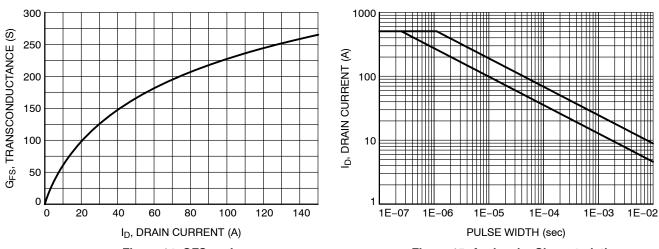


Figure 14. GFS vs. I_D

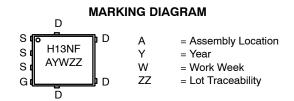
Figure 15. Avalanche Characteristics

ORDERING INFORMATION

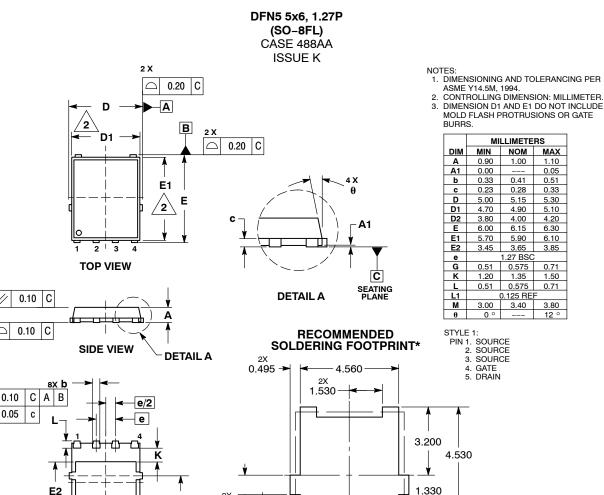
Device	Package	Shipping [†]
NTMFS4H013NFT1G	SO8-FL (Pb-Free)	1500 / Tape & Reel
NTMFS4H013NFT3G	SO8-FL (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





PACKAGE DIMENSIONS



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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PITCH

DIMENSIONS: MILLIMETERS

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